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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/802,866	SAITO ET AL.	
Examiner	Art Unit	
Mark A. Chapman	1756	

	SEARCHED			
Class	Subclass	Date	Examiner	
430	108.11	12/11/2005	МС	
	108.14			
	108.15			
	109.4			
•	137.15			
399	252			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
430	108.11	12/11/2005	MC	
	108.14			
	108.15			
109.4	137.15			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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east	12	/11/2005	МС
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